

Search Notes



Application/Control No.

10/799.316

Examiner

Tan V Mai

Applicant(s)/Patent under Reexamination

PITSIANIS ET AL.

SEARCHED

INTERFERENCE SEARCHED

| INTER-EXAMINEE CERTIFICATE | | | |
|----------------------------|----------|------|----------|
| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**